

<b>Notice of References Cited</b>		Application/Control No. 10/055,189	Applicant(s)/Patent Under Reexamination CAMPBELL ET AL.	
		Examiner Kimberly A. Williams	Art Unit 2625	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,333,790 B1	12-2001	Kageyama, Seiji	358/1.15
*	B	US-6,405,178 B1	06-2002	Manchala et al.	705/29
*	C	US-2002/0072998 A1	06-2002	Haines et al.	705/28
*	D	US-2002/0143642 A1	10-2002	Harper, Mark A.	705/26
*	E	US-6,529,692 B1	03-2003	Haines et al.	399/27
*	F	US-6,798,997 B1	09-2004	Hayward et al.	399/12
*	G	US-7,031,933 B2	04-2006	Harper, Mark A.	705/26
*	H	US-7,124,097 B2	10-2006	Claremont et al.	705/26
*	I	US-7,272,576 B2	09-2007	Matsugi, Hironori	705/29
*	J	US-2008/0015944 A1	01-2008	Nose et al.	705/22
*	K	US-2008/0215454	09-2008	Haines et al.	705/26
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.